

## 74LCX138

### Low Voltage 1-of-8 Decoder/Demultiplexer with 5V Tolerant Inputs

#### General Description

The LCX138 is a high-speed 1-of-8 decoder/demultiplexer. This device is ideally suited for high-speed bipolar memory chip select address decoding. The multiple input enables allow parallel expansion to a 1-of-24 decoder using just three LCX138 devices or a 1-of-32 decoder using four LCX138 devices and one inverter.

The 74LCX138 is fabricated with advanced CMOS technology to achieve high speed operation while maintaining CMOS low power dissipation.

#### Features

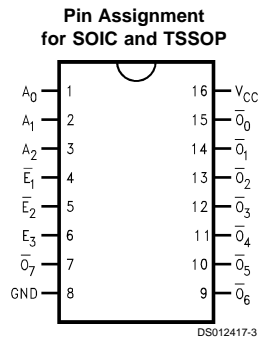
- 5V tolerant inputs
- 6.0 ns  $t_{PD}$  max, 10  $\mu$ A  $I_{CCQ}$  max
- Power down high impedance inputs and outputs
- Supports live insertion/withdrawal
- 2.0V–3.6V  $V_{CC}$  supply operation
- $\pm 24$  mA output drive
- Implements patented noise/EMI reduction circuitry
- Functionally compatible with 74 series 138
- Latch-up performance exceeds 500 mA
- ESD performance:
  - Human body model > 2000V
  - Machine model > 200V

#### Ordering Code:

Order Number	Package Number	Package Description
74LCX138M	M16A	16-Lead (0.150" Wide) Small Outline Package, JEDEC
74LCX138SJ	M16D	16-Lead Small Outline Package, SOIC EIAJ
74LCX138MTC	MTC16	16-Lead Thin Shrink Outline Package, TSSOP

Devices also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

#### Connection Diagram



#### Pin Descriptions

Pin Names	Description
$A_0$ – $A_2$	Address Inputs
$\bar{E}_1$ – $\bar{E}_2$	Enable Inputs
$E_3$	Enable Input
$\bar{O}_0$ – $\bar{O}_7$	Outputs

## Functional Description

The LCX138 high-speed 1-of-8 decoder/demultiplexer accepts three binary weighted inputs ( $A_0$ ,  $A_1$ ,  $A_2$ ) and, when enabled, provides eight mutually exclusive active-LOW outputs ( $\bar{O}_0$ – $\bar{O}_7$ ). The LCX138 features three Enable inputs, two active-LOW ( $\bar{E}_1$ ,  $\bar{E}_2$ ) and one active-HIGH ( $E_3$ ). All outputs will be HIGH unless  $\bar{E}_1$  and  $\bar{E}_2$  are LOW and  $E_3$  is

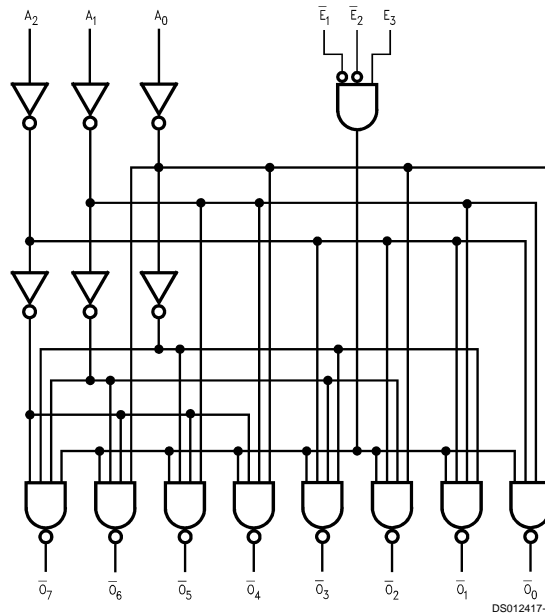
HIGH. The LCX138 can be used as an 8-output demultiplexer by using one of the active LOW Enable inputs as the data input and the other Enable inputs as strobes. The Enable inputs which are not used must be permanently tied to their appropriate active-HIGH or active-LOW state.

## Truth Table

Inputs						Outputs							
$\bar{E}_1$	$\bar{E}_2$	$E_3$	$A_0$	$A_1$	$A_2$	$\bar{O}_0$	$\bar{O}_1$	$\bar{O}_2$	$\bar{O}_3$	$\bar{O}_4$	$\bar{O}_5$	$\bar{O}_6$	$\bar{O}_7$
H	X	X	X	X	X	H	H	H	H	H	H	H	H
X	H	X	X	X	X	H	H	H	H	H	H	H	H
X	X	L	X	X	X	H	H	H	H	H	H	H	H
L	L	H	L	L	L	L	H	H	H	H	H	H	H
L	L	H	H	L	L	H	L	H	H	H	H	H	H
L	L	H	L	H	L	H	H	L	H	H	H	H	H
L	L	H	H	H	L	H	H	H	L	H	H	H	H
L	L	H	L	L	H	H	H	H	H	L	H	H	H
L	L	H	H	L	H	H	H	H	H	H	L	H	H
L	L	H	L	H	H	H	H	H	H	H	H	L	H
L	L	H	H	H	H	H	H	H	H	H	H	H	L

H = HIGH Voltage Level  
L = LOW Voltage Level  
X = Immaterial

## Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

## Absolute Maximum Ratings (Note 1)

Symbol	Parameter	Value	Conditions	Units
$V_{CC}$	Supply Voltage	-0.5 to +7.0		V
$V_I$	DC Input Voltage	-0.5 to +7.0		V
$V_O$	DC Output Voltage	-0.5 to $V_{CC} + 0.5$	Output in High or Low State (Note 2)	V
$I_{IK}$	DC Input Diode Current	-50	$V_I < GND$	mA
$I_{OK}$	DC Output Diode Current	-50	$V_O < GND$	mA
		+50	$V_O > V_{CC}$	
$I_O$	DC Output Source/Sink Current	$\pm 50$		mA
$I_{CC}$	DC Supply Current per Supply Pin	$\pm 100$		mA
$I_{GND}$	DC Ground Current per Ground Pin	$\pm 100$		mA
$T_{STG}$	Storage Temperature	-65 to +150		$^{\circ}C$

## Recommended Operating Conditions (Note 3)

Symbol	Parameter	Min	Max	Units	
$V_{CC}$	Supply Voltage	Operating	2.0	3.6	V
		Data Retention	1.5	3.6	
$V_I$	Input Voltage	0	5.5	V	
$V_O$	Output Voltage	0	$V_{CC}$	V	
$I_{OH}/I_{OL}$	Output Current	$V_{CC} = 3.0V-3.6V$		$\pm 24$	mA
		$V_{CC} = 2.7V$		$\pm 12$	
$T_A$	Free-Air Operating Temperature	-40	85	$^{\circ}C$	
$\Delta t/\Delta V$	Input Edge Rate, $V_{IN} = 0.8V-2.0V$ , $V_{CC} = 3.0V$	0	10	ns/V	

**Note 1:** The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the Absolute Maximum Ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

**Note 2:**  $I_O$  Absolute Maximum Rating must be observed.

**Note 3:** Unused inputs must be held HIGH or LOW. They may not float.

## DC Electrical Characteristics

Symbol	Parameter	Conditions	$V_{CC}$ (V)	$T_A = -40^{\circ}C$ to $+85^{\circ}C$		Units
				Min	Max	
$V_{IH}$	HIGH Level Input Voltage		2.7-3.6	2.0		V
$V_{IL}$	LOW Level Input Voltage		2.7-3.6		0.8	V
$V_{OH}$	HIGH Level Output Voltage	$I_{OH} = -100 \mu A$	2.7-3.6	$V_{CC} - 0.2$		V
		$I_{OH} = -12 \text{ mA}$	2.7	2.2		V
		$I_{OH} = -18 \text{ mA}$	3.0	2.4		V
		$I_{OH} = -24 \text{ mA}$	3.0	2.2		V
$V_{OL}$	LOW Level Output Voltage	$I_{OL} = 100 \mu A$	2.7-3.6		0.2	V
		$I_{OL} = 12 \text{ mA}$	2.7		0.4	V
		$I_{OL} = 16 \text{ mA}$	3.0		0.4	V
		$I_{OL} = 24 \text{ mA}$	3.0		0.55	V
$I_I$	Input Leakage Current	$0 \leq V_I \leq 5.5V$	2.7-3.6		$\pm 5.0$	$\mu A$
$I_{OFF}$	Power-Off Leakage Current	$V_I$ or $V_O = 5.5V$	0		10	$\mu A$
$I_{CC}$	Quiescent Supply Current	$V_I = V_{CC}$ or GND	2.7-3.6		10	$\mu A$
		$3.6V \leq V_I \leq 5.5V$	2.7-3.6		$\pm 10$	$\mu A$
$\Delta I_{CC}$	Increase in $I_{CC}$ per Input	$V_{IH} = V_{CC} - 0.6V$	2.7-3.6		500	$\mu A$

## AC Electrical Characteristics

Symbol	Parameter	$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}, C_L = 50\text{pF}, R_L = 500\Omega$				Units
		$V_{CC} = 3.3\text{V} \pm 0.3\text{V}$		$V_{CC} = 2.7\text{V}$		
		Min	Max	Min	Max	
$t_{PHL}$	Propagation Delay	1.5	6.0	1.5	7.0	ns
$t_{PLH}$	$A_n$ to $\bar{O}_n$	1.5	6.0	1.5	7.0	
$t_{PHL}$	Propagation Delay	1.5	6.5	1.5	7.5	ns
$t_{PLH}$	$E_3$ to $\bar{O}_n$	1.5	6.5	1.5	7.5	
$t_{PHL}$	Propagation Delay	1.5	6.0	1.5	7.0	ns
$t_{PLH}$	$\bar{E}_1$ or $\bar{E}_2$ to $\bar{O}_n$	1.5	6.0	1.5	7.0	
$t_{OSHL}$	Output to Output Skew (Note 4)		1.0			ns
$t_{OSLH}$			1.0			

**Note 4:** Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH to LOW ( $t_{OSHL}$ ) or LOW to HIGH ( $t_{OSLH}$ ).

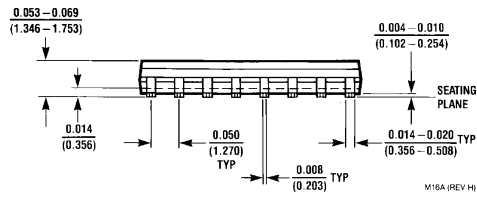
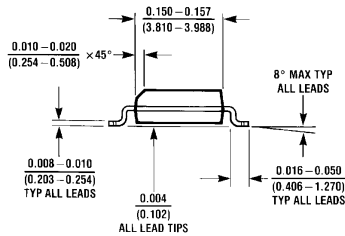
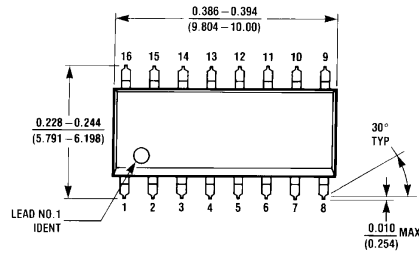
## Dynamic Switching Characteristics

Symbol	Parameter	Conditions	$V_{CC}$ (V)	$T_A = 25^{\circ}\text{C}$	Units
				Typical	
$V_{OLP}$	Quiet Output Dynamic Peak $V_{OL}$	$C_L = 50\text{ pF}, V_{IH} = 3.3\text{V}, V_{IL} = 0\text{V}$	3.3	0.8	V
$V_{OLV}$	Quiet Output Dynamic Valley $V_{OL}$	$C_L = 50\text{ pF}, V_{IH} = 3.3\text{V}, V_{IL} = 0\text{V}$	3.3	-0.8	V

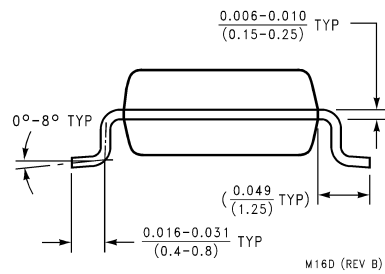
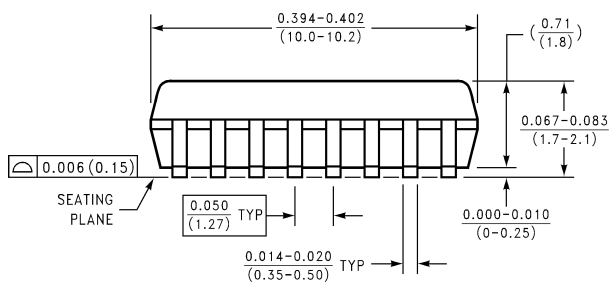
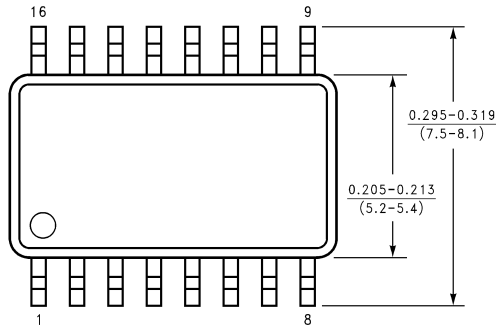
## Capacitance

Symbol	Parameter	Conditions	Typical	Units
$C_{IN}$	Input Capacitance	$V_{CC} = \text{Open}, V_I = 0\text{V or } V_{CC}$	7	pF
$C_{OUT}$	Output Capacitance	$V_{CC} = 3.3\text{V}, V_I = 0\text{V or } V_{CC}$	8	pF
$C_{PD}$	Power Dissipation Capacitance	$V_{CC} = 3.3\text{V}, V_I = 0\text{V or } V_{CC}, f = 10\text{ MHz}$	25	pF

**Physical Dimensions** inches (millimeters) unless otherwise noted

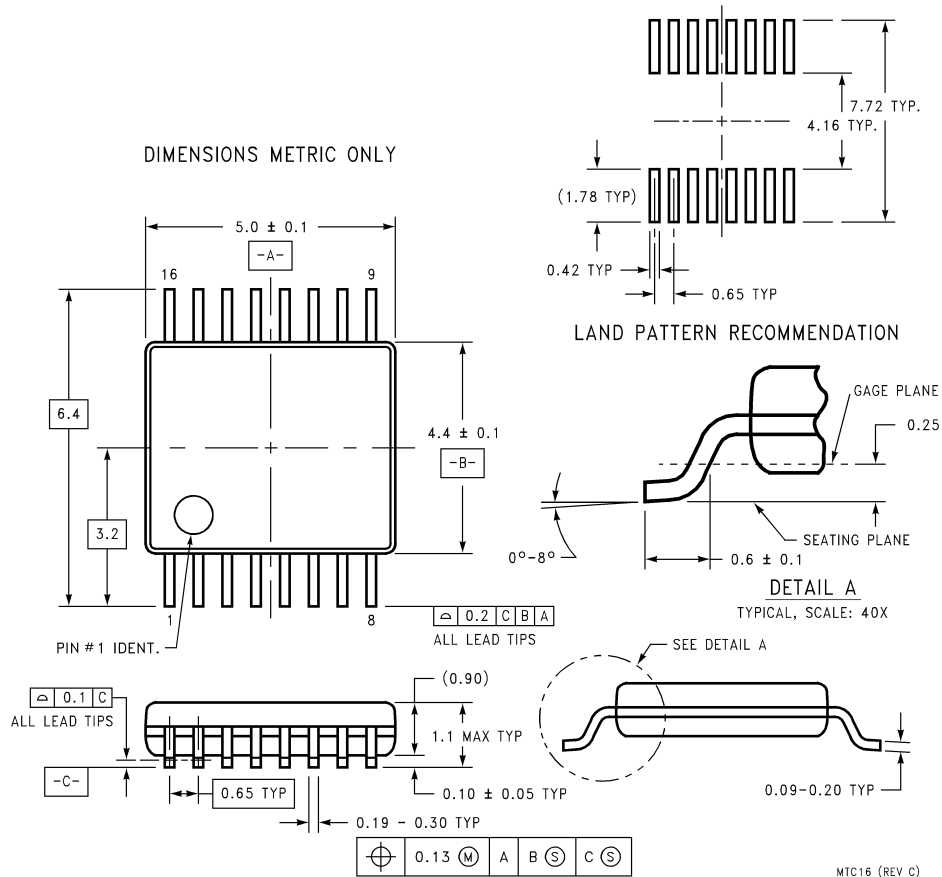


**16-Lead (0.0150" Wide) Molded Small Outline Package, JEDEC  
Package Number M16A**



**16-Lead Small Outline Package EIAJ (SJ)  
Package Number M16D**

**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



**16-Lead Thin Shrink Small Outline Package (MTC)**  
**Package Number MTC16**

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